Application/Control No.	Applicant(s)/Patent under Reexamination
10/562,484	KIM ET AL.
Examiner	Art Unit
Kien T. Nguyen	3711

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Class	Subclass	Date	Examiner
446	473	3/5/2007	KN
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH	STRATEGY	)
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see attached sheet	3/1/2007	KN
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